

Search Notes

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10/058,402

Examiner

Thien D. Tran

Applicant(s)/Patent under
Reexamination

KRONESTEDT ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/465,311,252	6/22/2006	TT